



February 2015

## FDMC6686P

### P-Channel PowerTrench<sup>®</sup> MOSFET

**-20 V, -56 A, 4 mΩ**

#### Features

- Max  $r_{DS(on)}$  = 4 mΩ at  $V_{GS} = -4.5$  V,  $I_D = -18$  A
- Max  $r_{DS(on)}$  = 5.7 mΩ at  $V_{GS} = -2.5$  V,  $I_D = -16$  A
- Max  $r_{DS(on)}$  = 11.5 mΩ at  $V_{GS} = -1.8$  V,  $I_D = -11$  A
- High performance trench technology for extremely low  $r_{DS(on)}$
- High power and current handling capability in a widely used surface mount package
- Lead-free and RoHS Compliant

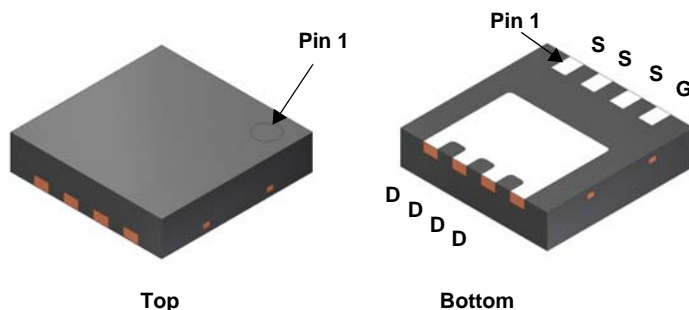


#### General Description

This P-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench<sup>®</sup> process that has been optimized for  $r_{DS(ON)}$ , switching performance and ruggedness.

#### Applications

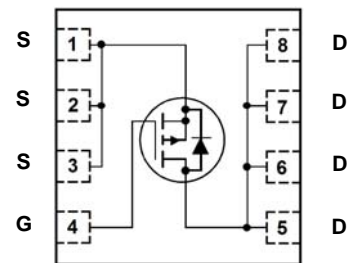
- Load Switch
- Battery Management
- Power Management
- Reverse Polarity Protection



Top

Bottom

Power 33



#### MOSFET Maximum Ratings $T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Ratings	Units
$V_{DS}$	Drain to Source Voltage	-20	V
$V_{GS}$	Gate to Source Voltage	$\pm 8$	V
$I_D$	Drain Current -Continuous $T_C = 25^\circ\text{C}$	-56	A
	-Continuous $T_A = 25^\circ\text{C}$ (Note 1a)	-18	
	-Pulsed (Note 3)	-377	
$P_D$	Power Dissipation $T_C = 25^\circ\text{C}$	40	W
	Power Dissipation $T_A = 25^\circ\text{C}$ (Note 1a)	2.3	
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ\text{C}$

#### Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.1	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	

#### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC6686P	FDMC6686P	Power 33	13 "	12 mm	3000 units

# Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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## Off Characteristics

$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = -250\ \mu\text{A}$ , $V_{GS} = 0\ \text{V}$	-20			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250\ \mu\text{A}$ , referenced to $25^\circ\text{C}$		-15		mV/ $^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = -16\ \text{V}$ , $V_{GS} = 0\ \text{V}$			-1	$\mu\text{A}$
$I_{GSS}$	Gate to Source Leakage Current	$V_{GS} = \pm 8\ \text{V}$ , $V_{DS} = 0\ \text{V}$			$\pm 100$	nA

## On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = -250\ \mu\text{A}$	-0.4	-0.75	-1	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = -250\ \mu\text{A}$ , referenced to $25^\circ\text{C}$		3		mV/ $^\circ\text{C}$
$r_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = -4.5\ \text{V}$ , $I_D = -18\ \text{A}$		3.3	4	m $\Omega$
		$V_{GS} = -2.5\ \text{V}$ , $I_D = -16\ \text{A}$		4.1	5.7	
		$V_{GS} = -1.8\ \text{V}$ , $I_D = -11\ \text{A}$		6	11.5	
		$V_{GS} = -4.5\ \text{V}$ , $I_D = -18\ \text{A}$ , $T_J = 125^\circ\text{C}$		4.3	6.5	
$g_{FS}$	Forward Transconductance	$V_{DS} = -5\ \text{V}$ , $I_D = -18\ \text{A}$		116		S

## Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = -10\ \text{V}$ , $V_{GS} = 0\ \text{V}$ , $f = 1\ \text{MHz}$		8800	13200	pF
$C_{oss}$	Output Capacitance			1520	2280	pF
$C_{rss}$	Reverse Transfer Capacitance			1340	2010	pF
$R_g$	Gate Resistance			6.2		$\Omega$

## Switching Characteristics

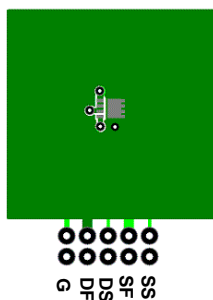
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = -10\ \text{V}$ , $I_D = -18\ \text{A}$ , $V_{GS} = -4.5\ \text{V}$ , $R_{GEN} = 6\ \Omega$		25	40	ns
$t_r$	Rise Time			77	122	ns
$t_{d(off)}$	Turn-Off Delay Time			317	506	ns
$t_f$	Fall Time			178	285	ns
$Q_g$	Total Gate Charge	$V_{DD} = -10\ \text{V}$ , $I_D = -18\ \text{A}$ , $V_{GS} = -4.5\ \text{V}$		87	122	nC
$Q_{gs}$	Gate to Source Charge			14		nC
$Q_{gd}$	Gate to Drain "Miller" Charge			24		nC

## Drain-Source Diode Characteristics

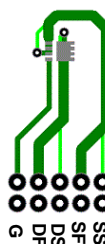
$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0\ \text{V}$ , $I_S = -18\ \text{A}$ (Note 2)		-0.7	-1.2	V
		$V_{GS} = 0\ \text{V}$ , $I_S = -2\ \text{A}$ (Note 2)		-0.6	-1.2	
$t_{rr}$	Reverse Recovery Time	$I_F = -18\ \text{A}$ , $di/dt = 100\ \text{A}/\mu\text{s}$		38	61	ns
$Q_{rr}$	Reverse Recovery Charge			24	39	nC

### NOTES:

- $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a.  $53^\circ\text{C}/\text{W}$  when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b.  $125^\circ\text{C}/\text{W}$  when mounted on a minimum pad of 2 oz copper.

- Pulse Test: Pulse Width < 300  $\mu\text{s}$ , Duty cycle < 2.0%.
- Pulse  $I_d$  refers to Forward Bias Safe Operation Area.

# Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

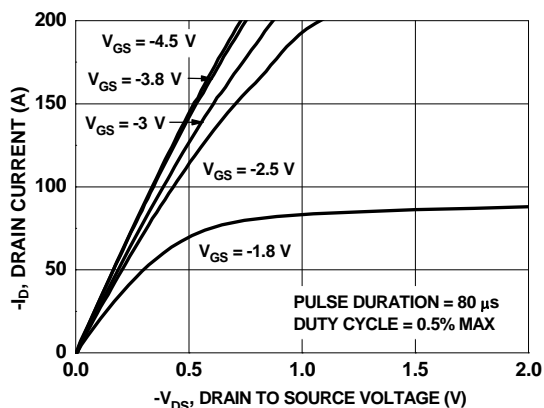


Figure 1. On-Region Characteristics

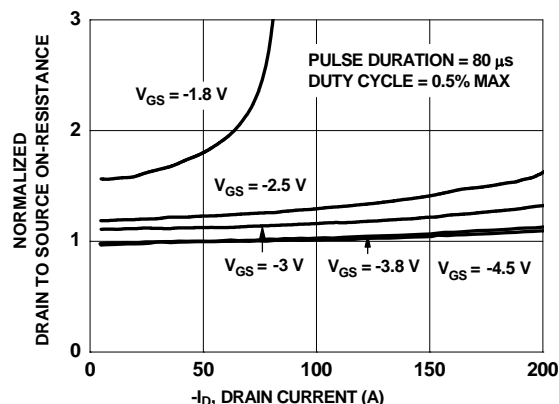


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

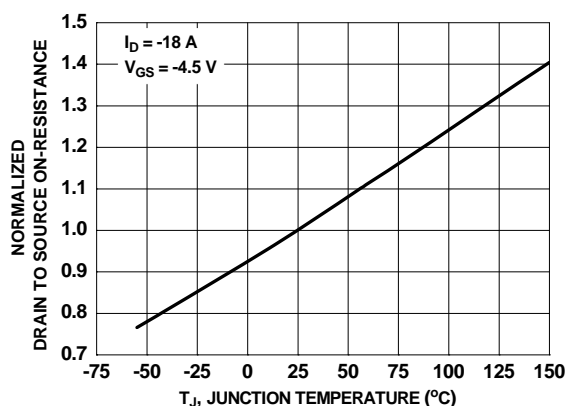


Figure 3. Normalized On-Resistance vs Junction Temperature

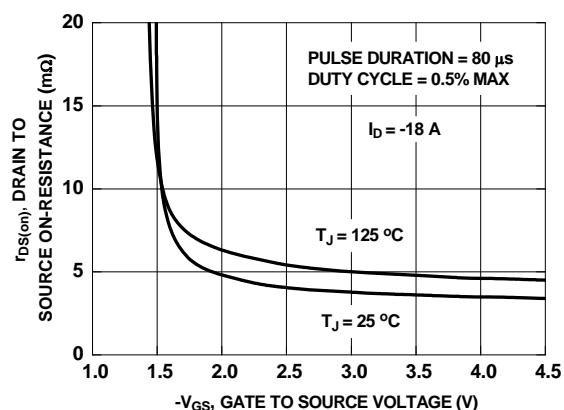


Figure 4. On-Resistance vs Gate to Source Voltage

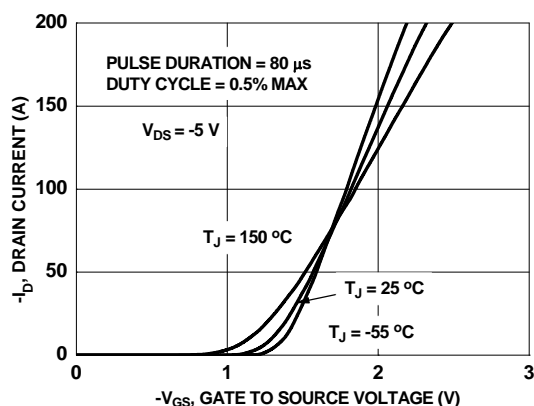


Figure 5. Transfer Characteristics

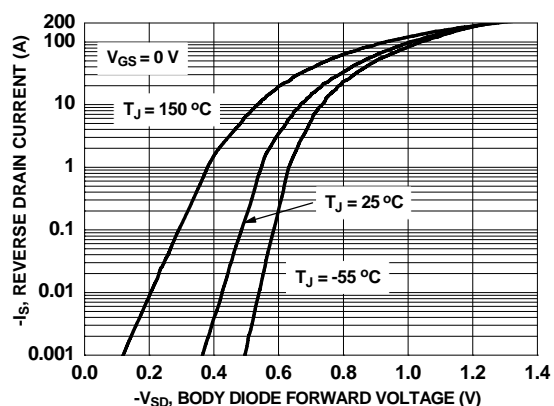


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

## Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

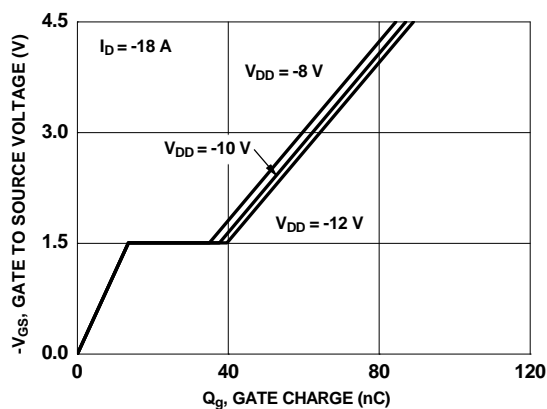


Figure 7. Gate Charge Characteristics

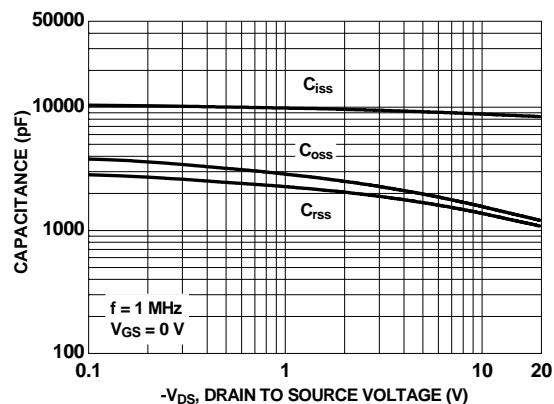


Figure 8. Capacitance vs Drain to Source Voltage

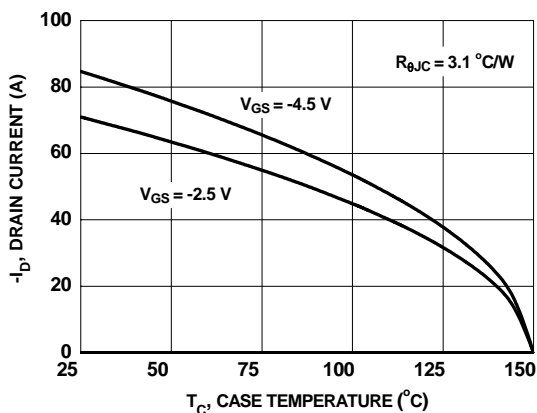


Figure 9. Maximum Continuous Drain Current vs Case Temperature

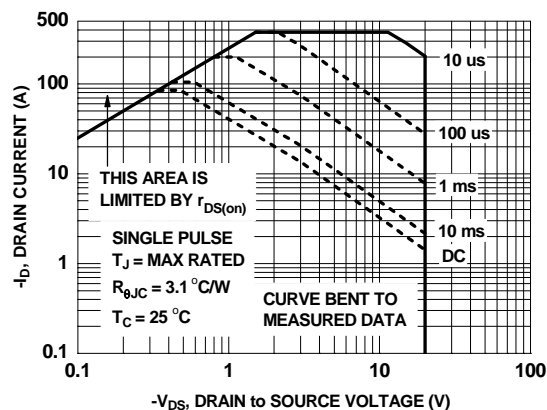


Figure 10. Forward Bias Safe Operating Area

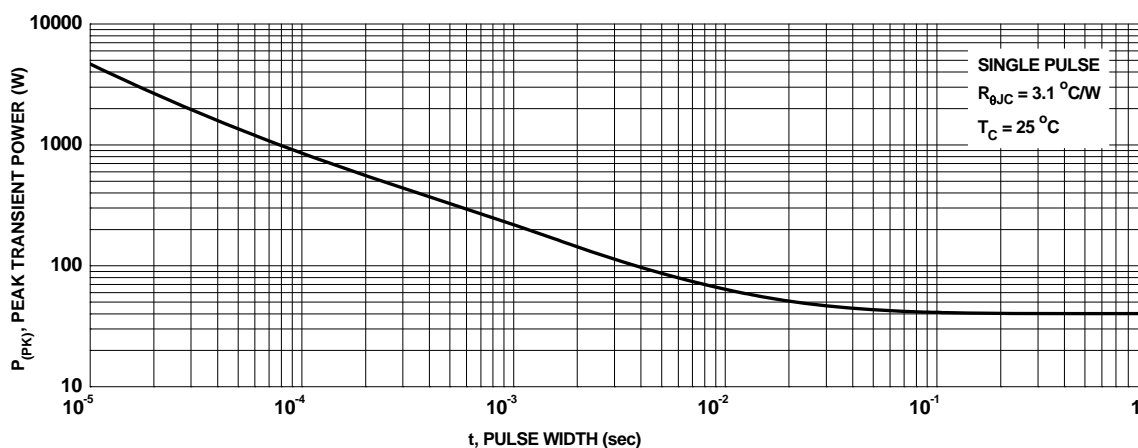


Figure 11. Single Pulse Maximum Power Dissipation

# Typical Characteristics $T_J = 25\text{ }^{\circ}\text{C}$ unless otherwise noted

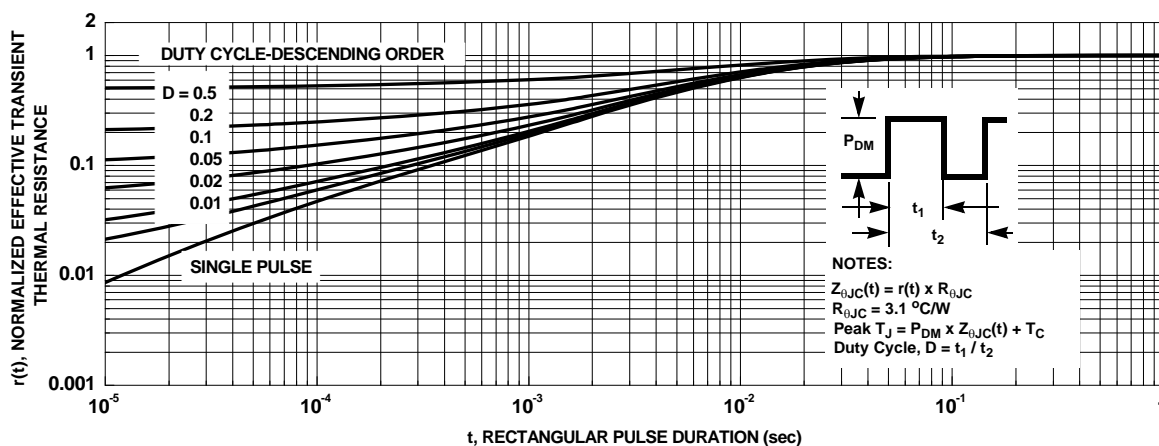
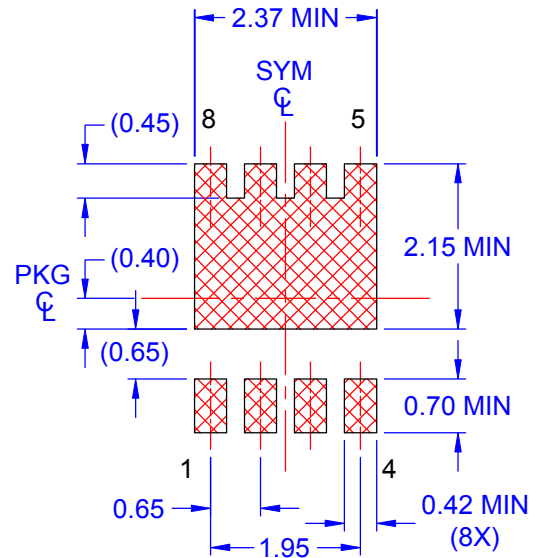
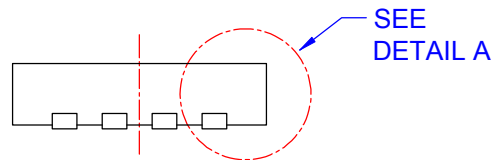
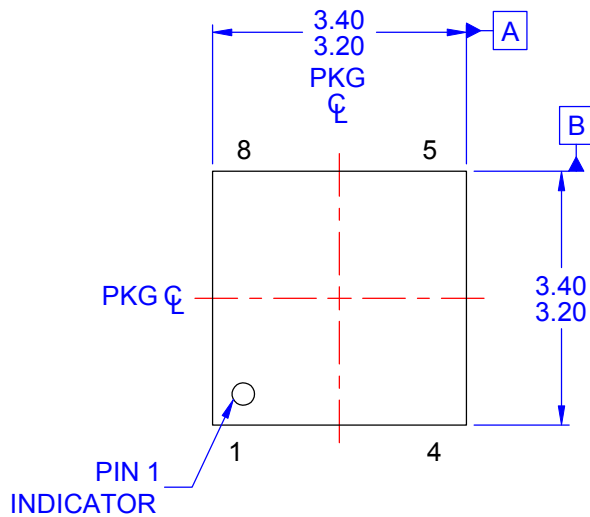
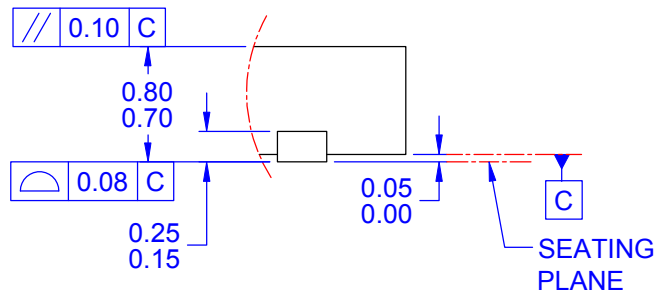
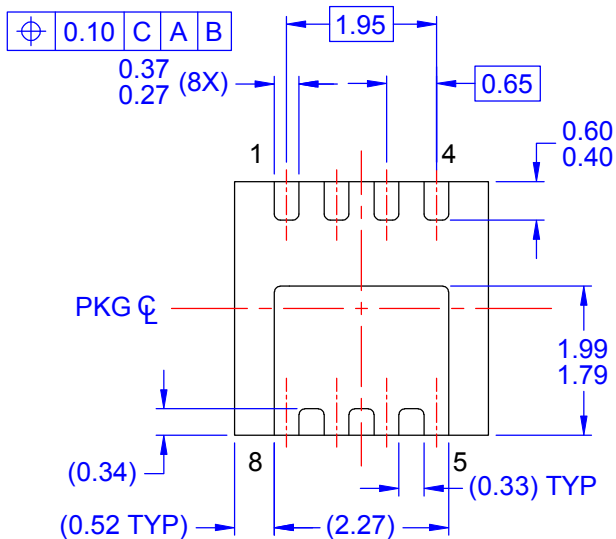


Figure 12. Junction-to-Case Transient Thermal Response Curve



LAND PATTERN  
RECOMMENDATION



DETAIL A  
SCALE: 2X

NOTES: UNLESS OTHERWISE SPECIFIED

- A) PACKAGE STANDARD REFERENCE:  
JEDEC MO-240, ISSUE A, VAR. BA,
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONS DO NOT INCLUDE BURRS  
OR MOLD FLASH. MOLD FLASH OR  
BURRS DOES NOT EXCEED 0.10MM.
- D) DIMENSIONING AND TOLERANCING PER  
ASME Y14.5M-2009.
- E) DRAWING FILE NAME: MKT-PQFN08SREV1



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